

ON Semiconductor®

# FDB86360-F085

N-Channel Power Trench® MOSFET **80V**, **110A**, **1.8m** $\Omega$ 

## **Features**

- Typ  $r_{DS(on)}$  = 1.5m $\Omega$  at  $V_{GS}$  = 10V,  $I_D$  = 80A
- Typ  $Q_{g(tot)}$  = 207nC at  $V_{GS}$  = 10V,  $I_D$  = 80A
- UIS Capability
- RoHS Compliant
- Qualified to AEC Q101

## **Applications**

- Automotive Engine Control
- Powertrain Management
- Solenoid and Motor Drivers
- Integrated Starter/alternator
- Primary Switch for 12V Systems



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= 25°C unles າ ວາກerwise notec MOSFET laximun.

Symbo	Palameter		Ratings	Units
V <sub>DS</sub>	ain to Source Voltage		80	V
V <sub>GS</sub>	Ge to Source Voltage		±20	V
	Drain Current - Continue us (V <sub>GS</sub> =10, (Note 1)	T <sub>C</sub> = 25°C	110	А
	Fulsed Drain Current	T <sub>C</sub> = 25°C	See Figure4	7
E <sub>AS</sub>	Single Pulse Avalanche Energy	(Note 2)	1167	mJ
	Power Dissipation		333	W
Pa	Derate above 25°C:		2.22	W/oC
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature		-55 to + 175	°C
$R_{\theta JC}$	Thermal Resistance Junction to Case		0.45	°C/W
$R_{\theta JA}$	Maximum Thermal Resistance Junction to Ambient	(Note 3)	43	°C/W

## **Package Marking and Ordering Information**

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDB86360	FDB86360-F085	D2-PAK(TO-263)	330mm	24mm	800 units

### Notes:

- 1: Current is limited by bondwire configuration.
  2: Starting T<sub>J</sub> = 25°C, L = 0.57mH, I<sub>AS</sub> = 64A, V<sub>DD</sub> = 80V during inductor charging and V<sub>DD</sub> = 0V during time in avalanche
- 3:  $R_{\theta JA}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta JA}$  is determined by the user's board design. The maximum rating presented here is based on mounting on a 1 in<sup>2</sup> pad of 2oz copper.

Units

Max

Тур

# **Electrical Characteristics** T<sub>J</sub> = 25°C unless otherwise noted

**Parameter** 

Off Characteristics							
B <sub>VDSS</sub>	Drain to Source Breakdown Voltage	I <sub>D</sub> = 250μA, \	/ <sub>GS</sub> = 0V	80	-	-	V
I <sub>DSS</sub>	Drain to Source Leakage Current	V <sub>DS</sub> =80V,	$T_{\rm J} = 25^{\rm o}{\rm C}$	-	-	1	μА
	Drain to Source Leakage Current	$V_{GS} = 0V$	$T_J = 175^{\circ}C(Note 4)$	-	-	1	mA
I <sub>GSS</sub>	Gate to Source Leakage Current	$V_{GS} = \pm 20V$		-	-	±100	nA

**Test Conditions** 

Min

## **On Characteristics**

Symbol

V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D}$	= 250μA	2.0	3 0			V
_	Drain to Source On Resistance	I <sub>D</sub> = 80A,	$T_{J} = 25^{\circ}C$	1	1.	1.8	4	$m\Omega$
r <sub>DS(on)</sub>	Dialit to Source Off Resistance	V <sub>GS</sub> = 10V	$T_J = 175^{\circ}C(Note 4)$		2.7	3.7	7	mΩ

## **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance	V 05V V 0V	.4600 -	pF
C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> = 25V, V <sub>GS</sub> = 0V,	470 -	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	- 1101112	470 -	pF
$R_g$	Gate Resistance	f = 1MH-	3.2	Q
$Q_{g(ToT)}$	Total Gate Charge at 10V	V <sub>C</sub> ) to 10	20 253	110
Q <sub>g(th)</sub>	Threshold Gate Charge	$V_{GS} = 2V$ $I_D = 80A$ -	2 51	nC
$Q_{gs}$	Gate to Source Gate Charge	06.0	78	nC
$Q_{gd}$	Gate to Drain "Miller" Charge	NV D	4777 -	nC

# Switching Character stics

t <sub>on</sub> Turn-	On ne	-	-	388	ns
t <sub>d(on)</sub>	n L ay Tim	-	75	-	ns
t <sub>r</sub> Rise	$V_{DD} = 40V, V_{D} = 80A,$	-	197	-	ns
t <sub>d(off)</sub>		-	86	-	ns
Fa	No VO VIV	-	70	-	ns
t <sub>off</sub> irn-	Off Time	-	-	226	ns

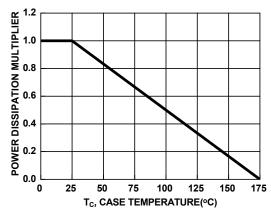
# Prair Source Diode Characteristics

1						
V	Source to Lirain Diode Vultage	$I_{SD} = 80A, V_{GS} = 0V$	-	-	1.25	٧
VSC	Source to Evalli block Shage	$I_{SD} = 40A, V_{GS} = 0V$	-	-	1.2	V
L <sup>at</sup>	Reverse Recovery Time	$I_F = 80A$ , $dI_{SD}/dt = 100A/\mu s$ ,	-	103	120	ns
Q <sub>rr</sub>	Reverse Recovery Charge	V <sub>DD</sub> =64V	-	212	260	nC

### Notes:

<sup>4:</sup> The maximum value is specified by design at  $T_J$  = 175°C. Product is not tested to this condition in production.

## **Typical Characteristics**



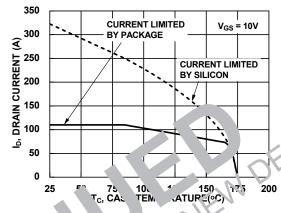
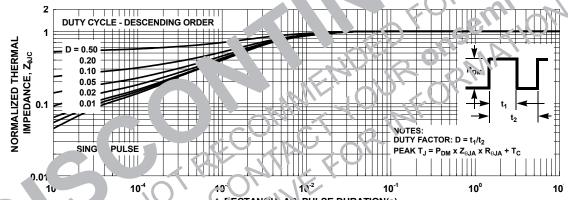


Figure 1. Normalized Power Dissipation vs Case Temperature

Figure 2. I. xin m C Itinuous brain Current vs. Case Temporature



t, FECTAMOULAN PULSE DURATION(s)
Figure 3. Normalized Maximum Transient Thermal Impedance

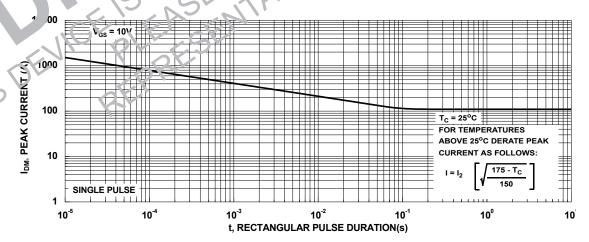


Figure 4. Peak Current Capability

# **Typical Characteristics**

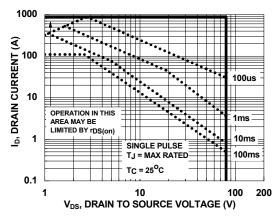
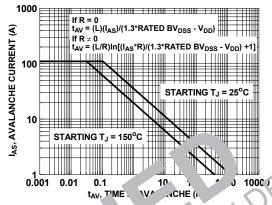
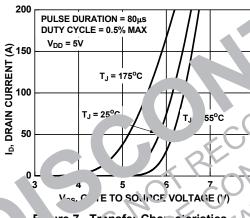


Figure 5. Forward Bias Safe Operating Area



NOTE: Refer to ON Sem. nduc Applic on Note: AN7514 and AN7515

Figure ( Un 'ampe Inductive Switching Car Jility



re 7. Transfer Characteristics

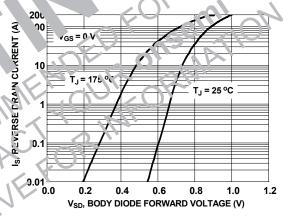


Figure 8. Forward Diode Characteristics

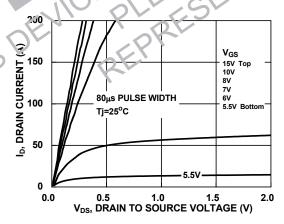


Figure 9. Saturation Characteristics

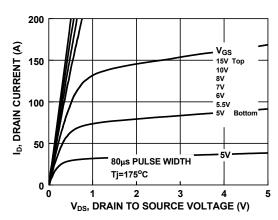


Figure 10. Saturation Characteristics

# **Typical Characteristics**

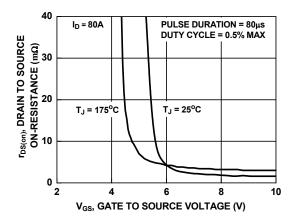


Figure 11. Rdson vs Gate Voltage

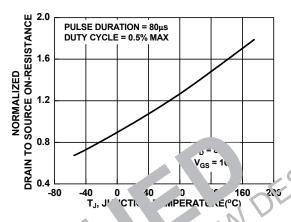
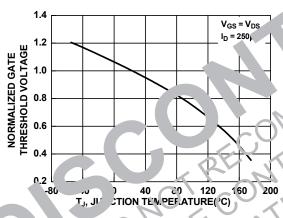


Figure 12 Norm zea son vs Junction
Ten erature



Figu 15 Normalized Gate Threshold Voltage vs Temperature

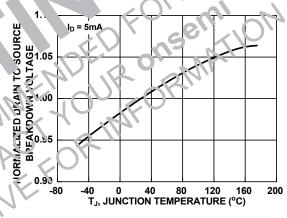


Figure 14. Normalized Drain to Source Breakdown Voltage vs Junction Temperature

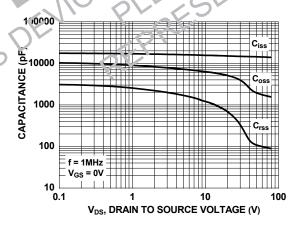


Figure 15. Capacitance vs Drain to Source Voltage

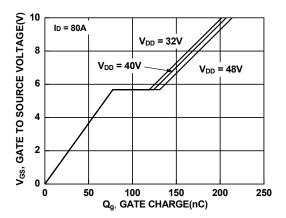


Figure 16. Gate Charge vs Gate to Source Voltage



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